Search Notes



Application/Control I	10.
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Reexamination
LUTZ ET AL.

Applicant(s)/Patent Under

Examiner

Art Unit

John A Tweel, Jr.

2612

SEARCHED

Class	Subclass	Date	Examiner
340	572.7	9/12/07	JAT
	572.5	9/12/07	JAT
235	492	9/12/07	JAT
343	748	9/12/07	JAT
	750	9/12/07	JAT
	806	9/12/07	JAT
	866	9/12/07	JAT
340	572.1	6/8/08	JAT

SEARCH NOTES

Search Notes	Date	Examiner
Ben Lee referred to classes 235 and 343	9/10/07	JAT
All classes searched	6/10/08	JAT

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
340	572.1	6/10/08	JAT
	572.7	6/10/08	JAT
343	806	6/10/08	JAT
	866	6/10/08	JAT

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